Attorney Docket No. 10031.000400

CLAIMS

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What is claimed is:

- A method of fabricating a solar cell, the method comprising:

 etching a first layer comprising copper without substantially etching a topmost metallic layer of a solar cell.
 - 2. The method of claim 1 wherein the topmost metallic layer comprises tin.
- 3. The method of claim 1 wherein the first layer is etched using an etchant comprising sulfuric acid and hydrogen peroxide.
- The method of claim 1 wherein the first layer is etched using an etchant
 comprising about 1% by volume of sulfuric acid, about 4% by volume of phosphoric acid,
 and about 2% by volume of stabilized hydrogen peroxide.
 - 5. The method of claim 1 wherein the first layer is etched using a Co-Bra Etch® etchant.
- 6. The method of claim 5 wherein the Co-Bra Etch[®] etchant is modified to comprise about 1% by volume of sulfuric acid, about 4% by volume of phosphoric acid, and about 2% by volume of stabilized hydrogen peroxide.
 - 7. The method of claim 1 wherein the first layer is etched using a Perma-Etch[®] etchant.
- The method of claim 1 wherein the topmost metallic layer comprises tin
 and the first layer is etched using an etchant comprising sulfuric acid and hydrogen peroxide.

potassium hydroxide.

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9. The method of claim 1 further comprising:

etching a second layer comprising titanium-tungsten using an etchant comprising hydrogen peroxide.

- 10. The method of claim 9 further comprising:
- etching a third layer comprising aluminum using an etchant comprising potassium hydroxide.
 - 11. The method of claim 1 further comprising:etching a second layer comprising aluminum using an etchant comprising
 - 12. The method of claim 11 wherein the etchant comprises about 1% by volume of potassium hydroxide in water.
 - 13. A method of etching a layer of material in a solar cell, the method comprising:

etching a copper layer selective to a tin layer using an etchant comprising sulfuric acid and hydrogen peroxide.

- 14. The method of claim 13 wherein the etchant comprises about 1% by volume of sulfuric acid, about 4% by volume of phosphoric acid, and about 2% by volume of stabilized hydrogen peroxide.
- 15. A method of etching a layer of material in a solar cell, the method20 comprising:

etching a metal layer without substantially etching a tin layer of a solar cell.

- 16. The method of claim 15 wherein the metal layer comprises copper.
- 17. The method of claim 15 wherein the metal layer comprises copper etched using an etchant comprising about 1% by volume of sulfuric acid, about 4% by volume of phosphoric acid, and about 2% by volume of stabilized hydrogen peroxide.
- 5 18. The method of claim 15 wherein the metal layer comprises copper etched using an etchant comprising hydrogen peroxide and sulfuric acid.
 - 19. The method of claim 15 wherein the metal layer comprises aluminum.
 - 20. The method of claim 15 wherein the metal layer comprises aluminum etched using an etchant comprising potassium hydroxide.
- 10 21. The method of claim 15 wherein the metal layer comprises aluminum etched using an etchant comprising about 1% by volume of potassium hydroxide in water.
 - 22. A method of etching a layer of material in a solar cell, the method comprising:
- etching an aluminum layer selective to a tin layer using an etchant comprising potassium hydroxide.
 - 23. The method of claim 22 wherein the etchant comprises about 1% by volume of potassium hydroxide in water.
- 24. An etchant for removing portions of a copper layer in a solar cell without
 20 substantially etching a solderable tin layer, the etchant comprising hydrogen peroxide
 and sulfuric acid.

- 25. The etchant of claim 24 wherein the etchant comprises about 1% by volume of sulfuric acid, about 4% by volume of phosphoric acid, and about 2% by volume of stabilized hydrogen peroxide.
- 26. An etchant for removing portions of an aluminum layer in a solar cell
 without excessively etching a tin layer, the etchant comprising potassium hydroxide.
 - 27. The etchant of claim 26 wherein the etchant comprises about 1% by volume of potassium hydroxide in water.
- 28. A method of fabricating a solar cell, the method comprising:
 etching a first layer comprising aluminum without substantially etching a
 topmost metallic layer of a solar cell.
 - 29. The method of claim 28 wherein the topmost metallic layer comprises tin.
 - 30. The method of claim 28 wherein the first layer is etched using an etchant comprising potassium hydroxide.
- 31. The method of claim 30 wherein the etchant comprises about 1% byvolume of potassium hydroxide in water.
 - 32. The method of claim 28 wherein the first layer is etched using an etchant that is selective to an oxide layer under the first layer.